TOSHIBA BIPOLAR DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TD62387AFNG, TD62388AFNG

8CH LOW INPUT ACTIVE DARLINGTON SINK DRIVER

The TD62387AFNG and TD62388AFNG are non-inverting transistor arrays, which are comprised of eight NPN darlington output stages and PNP input stages.

All unites feature integral clamp diodes for switching inductive loads.

These devices are Low Level input active drivers and are suitable for operations with TTL, 5 V CMOS and 5 V Microprocessor which have sink current output drivers.

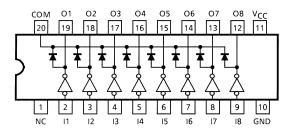
Applications include relay, hammer, lamp and LED driver. This devices are a product for the Pb free(Sn-Ag).

FEATURES

- Package Type :SSOP20 pin (0.65 mm pitch)
- High Sustaining Voltage : 50 V (Min)
- Output Current (Single Output) : 500 mA / ch (Max)
- Output Clamp Diodes
- Input
 :LOW LEVEL ACTIVE
- Standard Supply Voltage
- Inputs Compatible with TTL and 5 V CMOS

TYPE	V _{IN(ON)}
TD62387AFNG	0 V~V _{CC} - 3.7 V
TD62388AFNG	0 V V UC = 3.7 V

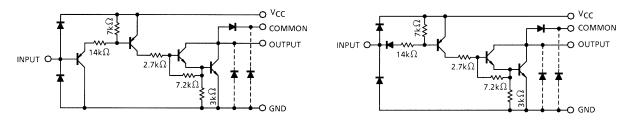
PIN CONNECTION (TOP VIEW)



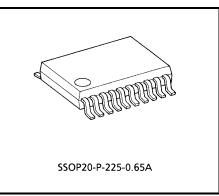
SCHEMATICS (EACH DRIVER)

TD62387AFNG

TD62388AFNG



Note: The input and output parasitic diodes cannot be used as clamp diodes.



Weight: 0.09 g (Typ.)

MAXIMUM RATINGS (Ta = 25°C)

SYMBOL	RATING	UNIT	
V _{CC}	-0.5~7.0	V	
V _{CE (SUS)}	-0.5~50	V	1
I _{OUT}	500	mA / ch	
V _{IN}	-0.5~7.0	V	
I _{IN}	-10	mA	
V _R	50	V	
١ _F	500	mA	
PD	0.96 (Note)	W	1
T _{opr}	-40~85	°C	
T _{stg}	-55~150	°C	
	V _{CC} V _{CE} (SUS) I _{OUT} V _{IN} I _{IN} V _R I _F P _D T _{opr}	V _{CC} -0.5~7.0 V _{CE} (SUS) -0.5~50 I _{OUT} 500 V _{IN} -0.5~7.0 I _{IN} -10 V _R 50 I _F 500 P _D 0.96 (Note) T _{opr} -40~85	V _{CC} -0.5~7.0 V V _{CE} (SUS) -0.5~50 V I _{OUT} 500 mA / ch V _{IN} -0.5~7.0 V I _{IN} -10 mA V _R 50 V I _F 500 mA P _D 0.96 (Note) W T _{opr} -40~85 °C

Note: On Glass Epoxy PCB (50 × 50 × 1.6 mm Cu 40%)

RECOMMENDED OPERATING CONDITIONS (Ta = -40~85°C)

CHARACTERISTIC	SYMBOL	CONDITION		MIN	TYP.	MAX	UNIT
Supply Voltage	V _{CC}			4.5	5.0	5.5	V
Output Sustaining Voltage	V _{CE (SUS)}		0	_	50	V	
Output Current	I _{OUT} (Note)	DC 1 Circuit		0	_	350	
		$T_{pw} = 25 \text{ ms}$ 8 Circuits Ta = 85°C T _j = 120°C	Duty = 10%	0	_	180	mA / ch
			Duty = 50%	0	_	90	
Input Voltage	V _{IN}			0	—	5.5	V
Clamp Diode Reverse Voltage	V _R			—	—	50	V
Clamp Diode Forward Current	١ _F			—	—	400	mA
Power Dissipation	PD			_	—	0.4	W

Note: On Glass Epoxy PCB (50 × 50 × 1.6 mm Cu 40%)

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

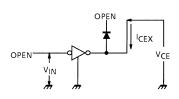
CHARACTERISTIC		SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN	TYP.	MAX	UNIT
Output Leakage Current		ICEX	1	V _{CC} = 5.5 V, I _{IN} = 0 V _{OUT} = 50 V, Ta = 85°C	_	_	100	μA
Output Saturation Voltage		V _{CE (sat)}	2	V _{CC} = 4.5 V V _{IN} = V _{IN (ON)} Max _. I _{OUT} = 350 mA	_	1.4	2.0	v
Input Current	Output On		3	V _{CC} = 5.5 V, V _{IN} = 0.4 V	-	-0.32	-0.45	mA
		I _{IN} (ON)		V_{CC} = 5.5 V, V_{IN} = -20 V	-	_	-2.6	ma
	Output Off	I _{IN (OFF)}	4		-	_	-4.0	μA
Input Voltage (Output on)		V _{IN (ON)}	5		_	_	V _{CC} - 3.7	V
Clamp Diode Reverse Current			6	V _R = 50 V, Ta = 25°C (Note 1)		_	50	μA
		I _R		V _R = 50 V, Ta = 85°C (Note 1)		—	100	
Clamp Diode Forward Current		VF	7	I _F = 350 mA	-	_	2.0	v
		٧F		I _F = 280 mA	-	_	1.8	
Supply Current		I _{CC (ON)}	- 8	V _{CC} = 5.5 V, V _{IN} = 0	_	17	22	mA
		I _{CC (OFF)}		V_{CC} = 5.5 V, V_{IN} = V_{CC}	_	_	100	μA
Turn-On Delay		t _{ON}	9	$V_{CC} = 5 V, V_{OUT} = 50 V(Note1)$ R _L = 125 Ω, C _L = 15 pF	_	0.1	_	μs
Turn-Off Delay		tOFF	, and the second		_	3	_	

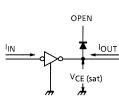
TEST CIRCUIT

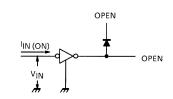
1. I_{CEX}



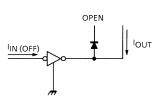






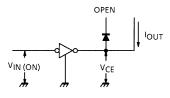


4. I_{IN (OFF)}

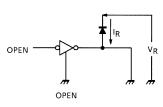


5. V_{IN (ON)}

6. I_R



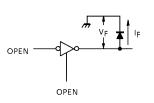


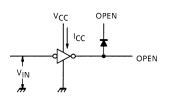


7. V_F

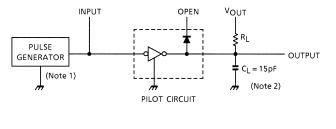
TOSHIBA

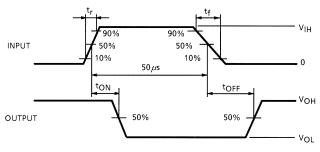






9. ton, toff





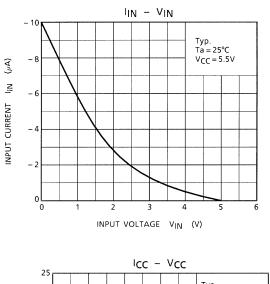
Note 1: Pulse Width 50 μ s, Duty Cycle 10% Output Impedance 50 Ω , t_r ≤ 5 ns, t_f ≤ 10 ns Note 2: C_L includes probe and jig capacitance.

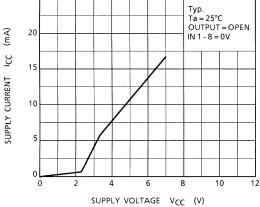
PRECAUTIONS for USING

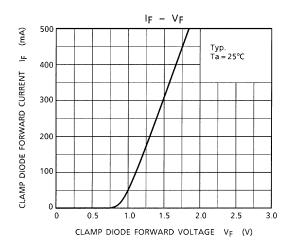
This IC does not integrate protection circuits such as overcurrent and overvoltage protectors. Thus, if excess current or voltage is applied to the IC, the IC may be damaged. Please design the IC so that excess current or voltage will not be applied to the IC.

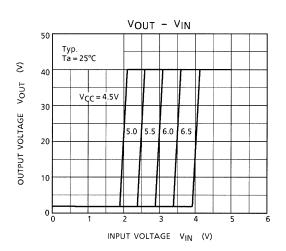
Utmost care is necessary in the design of the output line, V_{CC}, COMMON and GND line since IC may be destroyed due to short-circuit between outputs, air contamination fault, or fault by improper grounding.

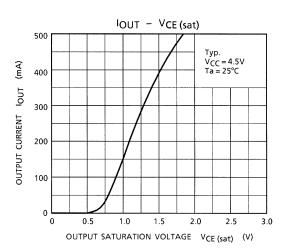
TOSHIBA



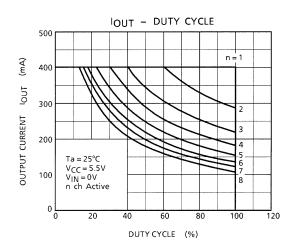


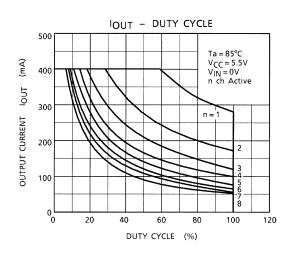


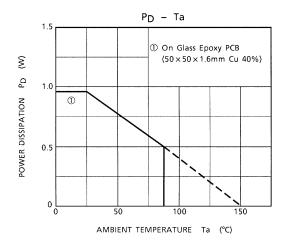




TOSHIBA







TOSHIBA

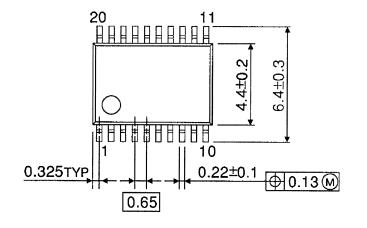
PACKAGE DIMENSIONS

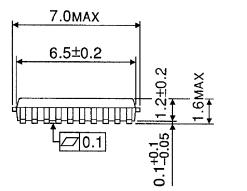
SSOP20-P-225-0.65A

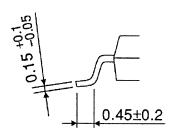
Unit: mm

(225mil)

5.72







Weight: 0.09 g (Typ.)

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About solderability, following conditions were confirmed
Solderability

(1) Use of Sn-63Pb solder Bath
solder bath temperature = 230°C
dipping time = 5 seconds
the number of times = once
use of R-type flux

(2) Use of Sn-3.0Ag-0.5Cu solder Bath

solder bath temperature = 245°C
dipping time = 5 seconds
the number of times = once
use of R-type flux
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